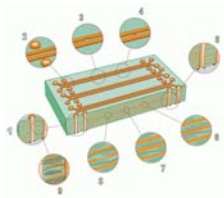




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## **TDR, S-Parameters & Differential Measurements**



### **Agenda**

Introduction

TDR theory of operation

Real Example: Samtec Golden Standard Board

- Single Ended Impedance
- Coupling Effects
- Odd & Even Modes
- Differential Impedance

Relating TDR/TDT & S-Parameters

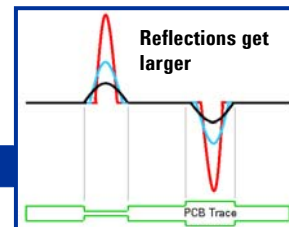
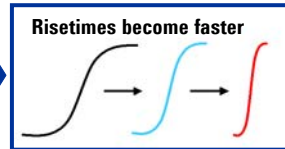
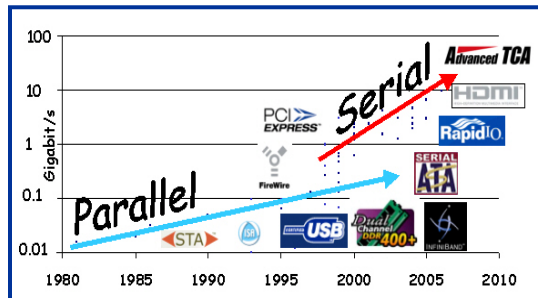
- TDR – more than reflections
- 4-Port Single Ended vs 2-Port Mixed Mode (Differential)

Important Factors in DTDR Accuracy



## Signal Integrity Challenge

Data Rates Increase >1Gbps



Frequency Domain Data is Now Required



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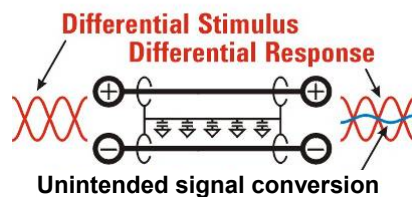
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## Trend to Differential Topologies

- **Ideal differential devices**
  - Low voltage requirements
  - Noise and EMI immunity
  - Virtual grounding
- **Non-ideal devices are not symmetric**
  - Can be identified by signal-conversions
    - Differential → Common
    - Common → Differential
- **Differential signal integrity design tools are needed**

### Differential Structure



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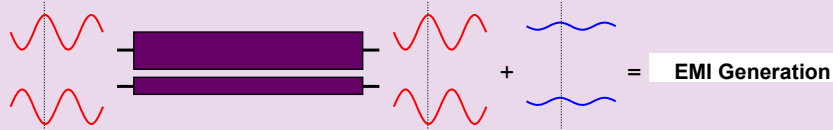
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## What About Non-Ideal Devices?

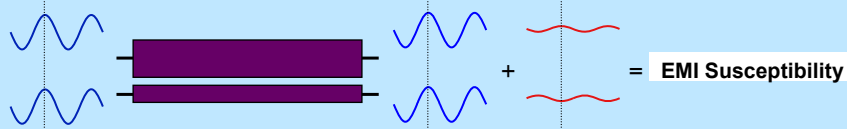
Undesirable signal conversions cause emission or susceptibility problems

### • Differential-stimulus to common-response conversion



Imperfectly matched lines mean the electromagnetic fields of the signals are not as well confined as they should be – giving rise to generation of interference to neighboring circuits.

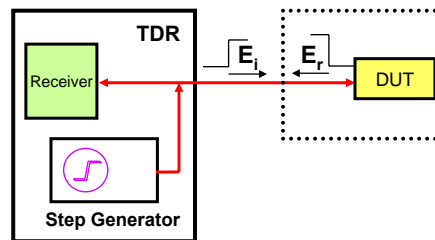
### • Common-stimulus to differential-response conversion



Imperfectly matched lines mean that interfering signals do not cancel out completely when subtraction occurs at the receiver. Measured by stimulating common-signal to simulate interference.

## Theory of Operation - TDR

### Impedance



**Time Domain Reflectometer  
(TDR)**

## Impedance Mismatch Terms

$$Z_L = Z_0 \frac{1 + \rho}{1 - \rho}$$

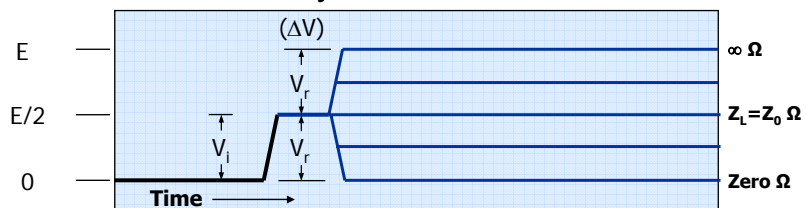
Impedance Calculated from  
Source Impedance and  
Reflection Coefficient.

$$\rho = \frac{V_r}{V_i}$$

Reflection Coefficient, rho:  
How much was reflected?

What is the value of  $Z_{load}$ ?

The DCA automatically calculates this for us.

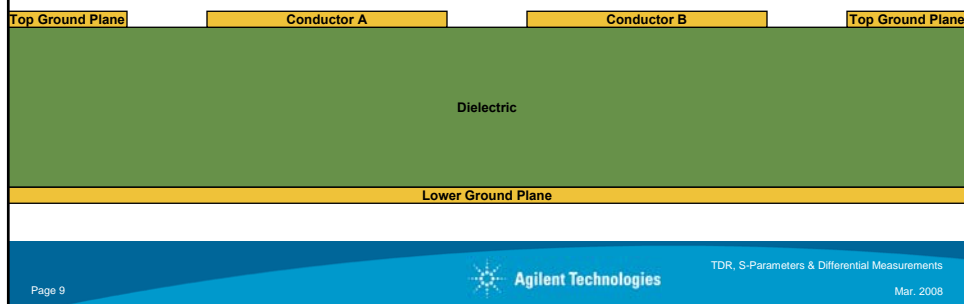


## The Samtec Golden Standard Reference Board



Details on [www.samtec.com](http://www.samtec.com)

## Samtec Board Cross Section



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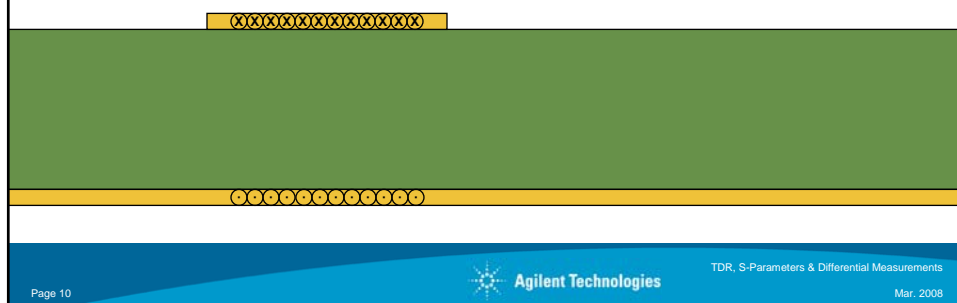
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## Basic Microstrip Example

⊗ = Current into page  
⊙ = Current out of page

- As Positive Voltage Step is launched into conductor, positive charge is added to the conductor creating a current.
- Impedance is defined by the geometry and material properties – *independent of the voltage applied.*
- Wider conductor or thinner dielectric increases capacitance,  $Z \propto \frac{1}{C}$  decreases impedance
- If Voltage is doubled, current is doubled,  $Z = \frac{v}{i}$

A



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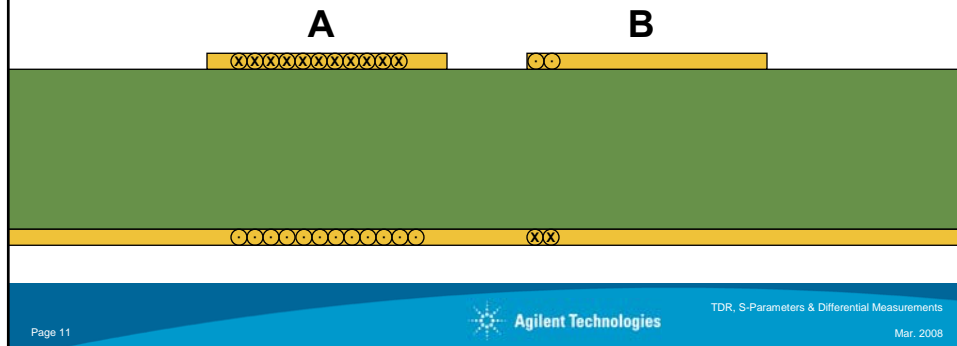
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## Coupling Effect on Single Ended Impedance

- Adding other nearby conductors causes field lines to couple to the other conductor instead of the return path
- Capacitance to ground is reduced slightly
- Single Ended Impedance of primary conductor is increased slightly
- Induced Voltage & Currents on adjacent conductor create Near and Far End Crosstalk, NEXT/FEXT



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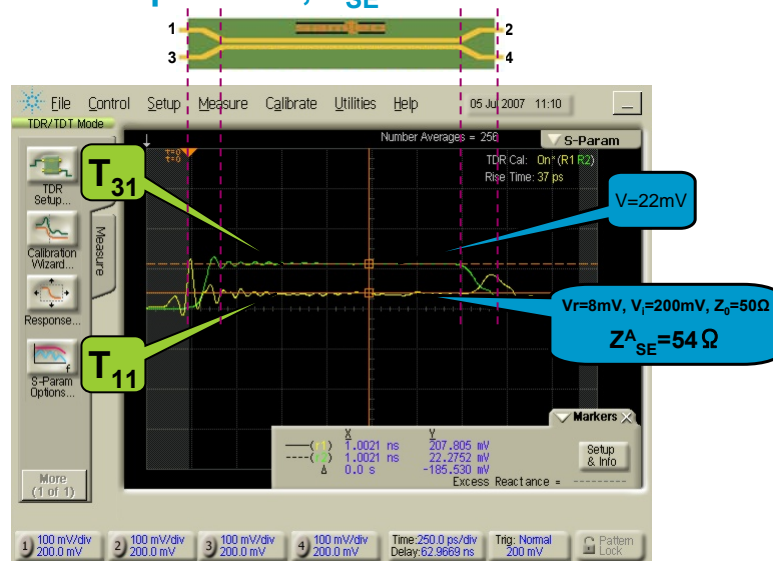
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## Single Ended Impedance, $Z_{SE}$ of A

- Stimulus on Port 1 only



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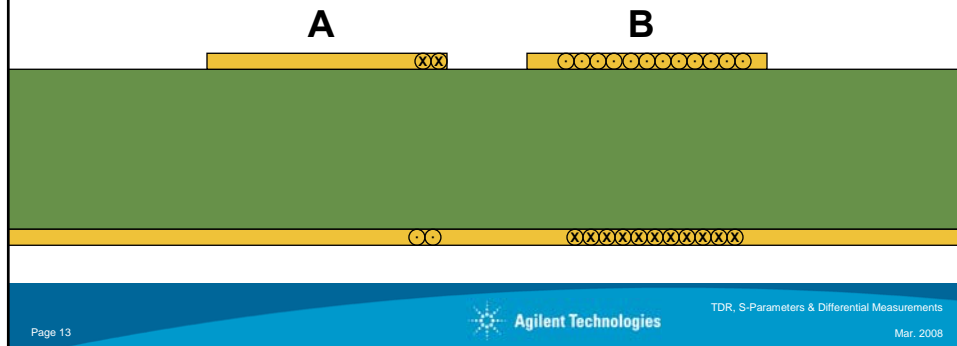
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## Single Ended Impedance of B

- Exactly same as A
- Can be measured with either positive or negative voltage step at various amplitudes (linear)



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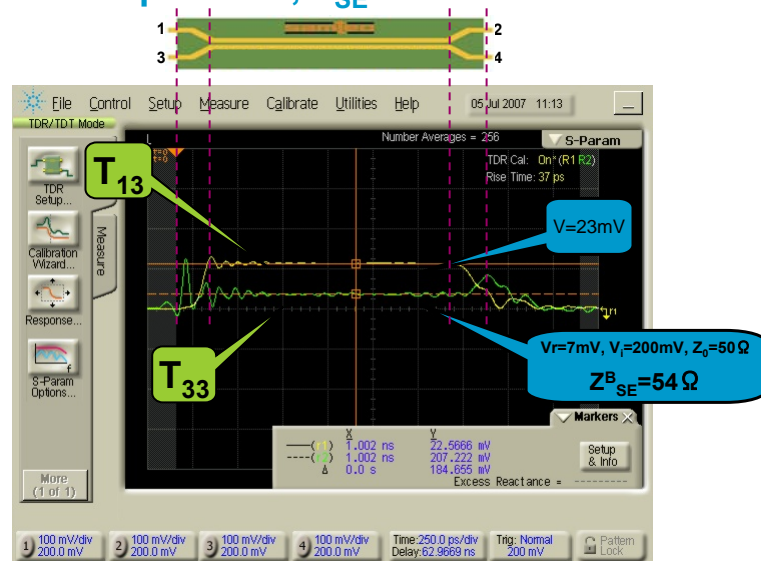
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## Single Ended Impedance, $Z_{SE}$ of B

• Stimulus on Port 3 only



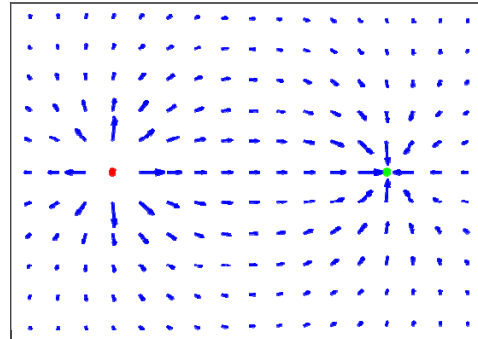
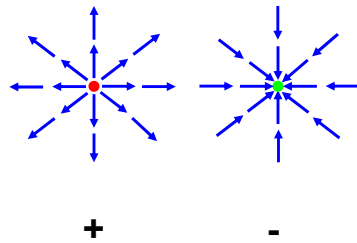
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## Vector Addition of Field Lines



## Simultaneous Stimulation

- Since the voltages/currents add/cancel, results can be calculated from independent measurements

*"The amount of voltage that might couple onto a quiet net from an active net is completely independent of the voltage that might already be present on the quiet net"*

Dr. Eric Bogatin – Signal Integrity Simplified  
Prentice Hall

**A**

**B**





## Differential Circuit Terminology

- Odd Mode Impedance**

- Impedance of a single line, while the pair is driven in the odd mode (only differential signal, no common signal).

- Even Mode Impedance**

- Impedance of a single line, while the pair is driven in the even mode (only common signal, no differential).

- Differential Impedance**

- Impedance the differential part of a signal will see. (Sum of the Odd Mode Impedances)

- Common Impedance**

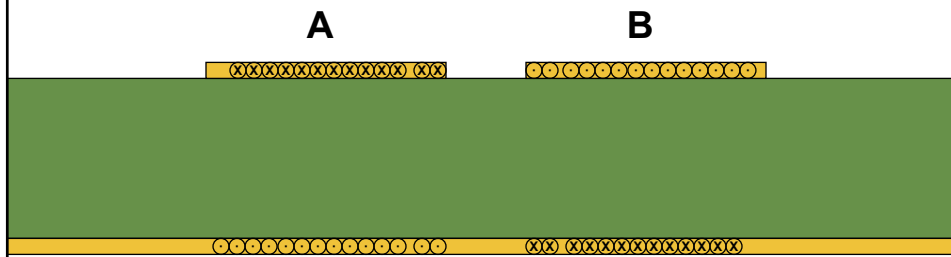
- Impedance the common part of a signal will see. (Sum of Even Mode Impedances/4)

## Odd Mode Impedance

- Defined as Impedance of a single line when voltage on A is opposite polarity of voltage on B**

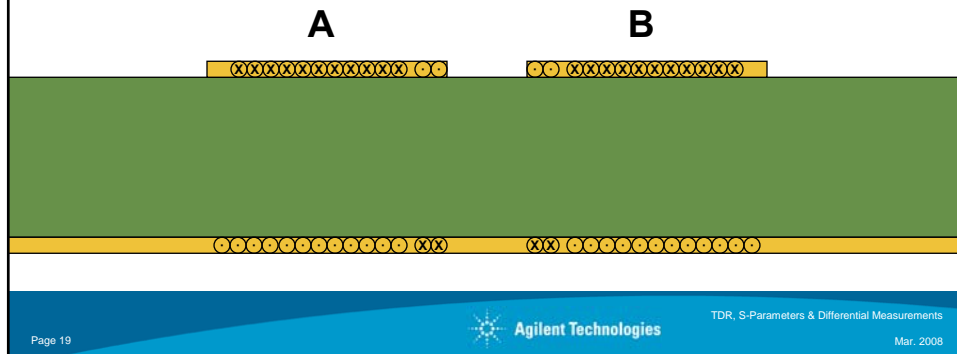
- Can be measured either by stimulating both lines simultaneously OR combining currents/voltages from independent measurements**

- **$Z_{\text{odd}}$  is less than  $Z_{\text{SE}}$  due to induced currents combining (more current = less impedance)**

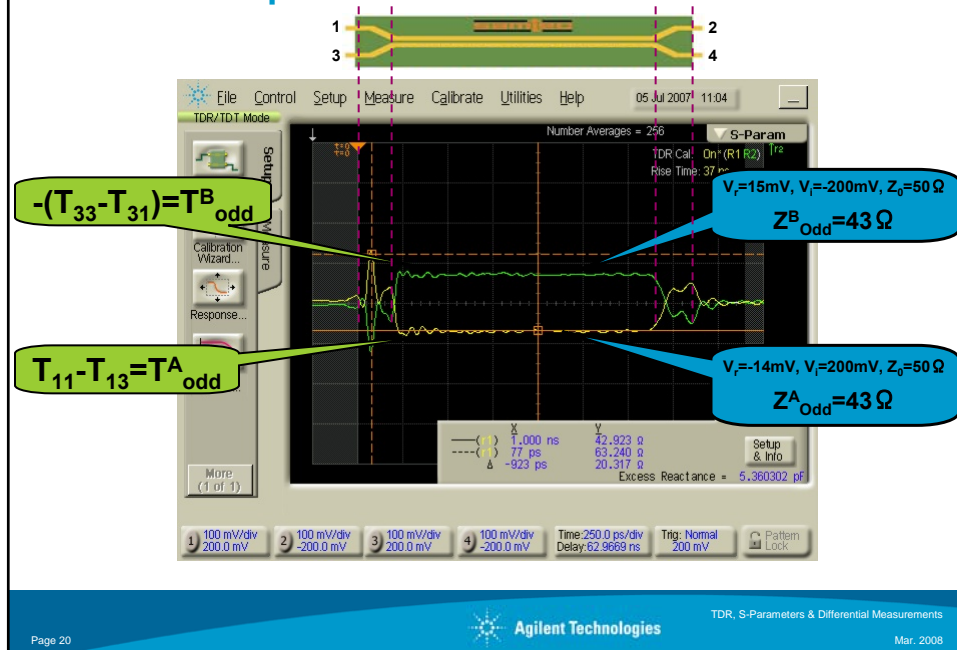


## Even Mode Impedance

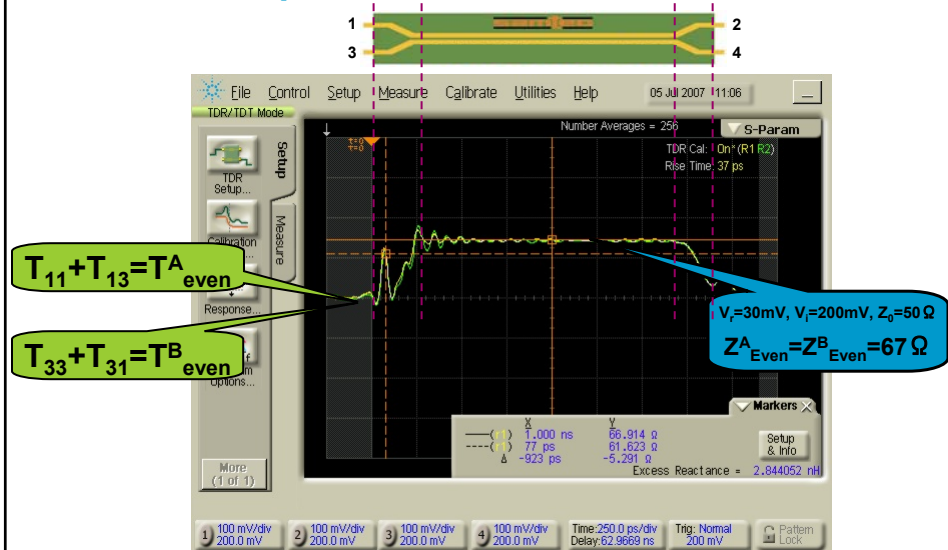
- Defined as Impedance of a single line when voltage on A is identical to voltage on B
- Can be measured either by stimulating both lines simultaneously OR combining currents/voltages from independent measurements
- $Z_{\text{even}}$  is **more** than  $Z_{\text{SE}}$  since induced currents **oppose** each other (less current = more impedance)



## Odd Mode Impedances



## Even Mode Impedances



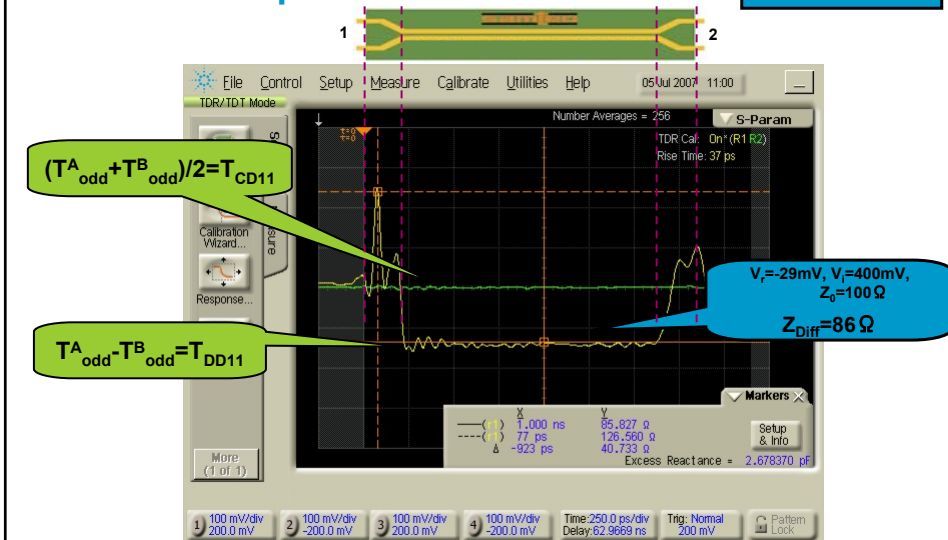
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## Differential Impedance



•Samtec simulated  $Z_{\text{Diff}} = 86.6\Omega$

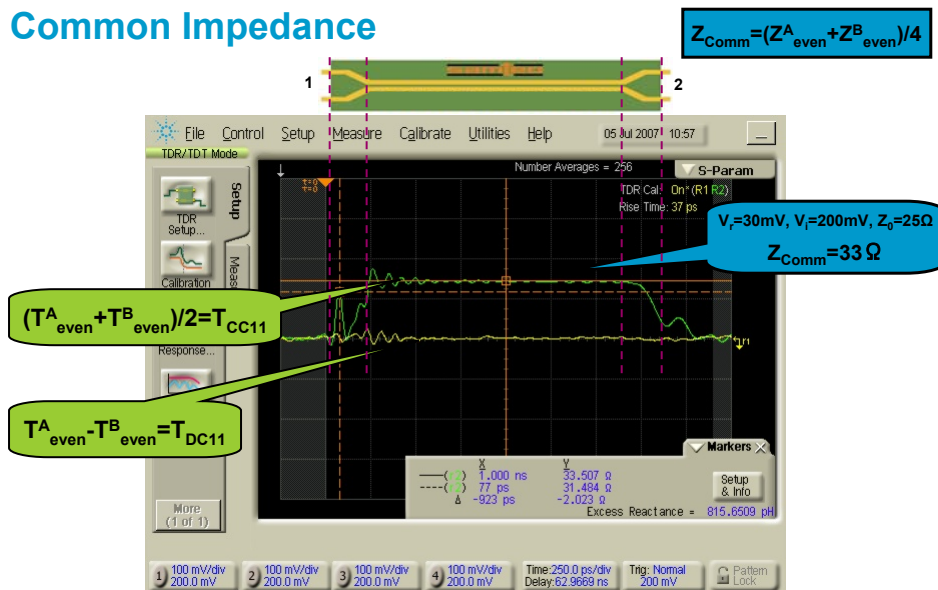
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## Common Impedance



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*"Try using your single-ended TDR to make any two of the following measurements. From these measurements, you can work out the true differential impedance:*

- The impedance of one trace while the other is reasonably well-terminated at both ends.*
- The impedance when both traces are ganged together in parallel.*
- The near-end crosstalk induced on the second trace when the first is driven.*

*The necessary equations are pretty hairy, but you don't have to know them."*

Howard Johnson, PhD – EDN Article, 8/22/2002

<http://www.edn.com/article/CA238428.html>

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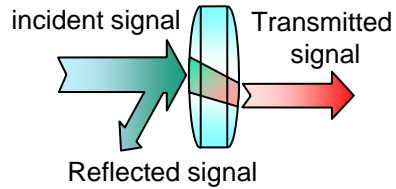
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## Understanding S-Parameters

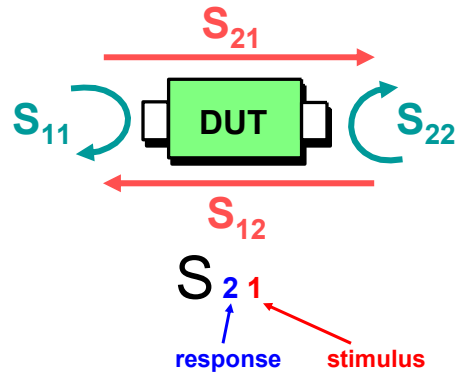
### Optical Device (Lens)



Reflection  $\rightarrow S_{11}, S_{22}$

Transmission  $\rightarrow S_{21}, S_{12}$

### Electrical Device (PCB)



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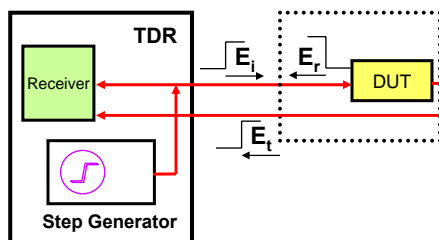
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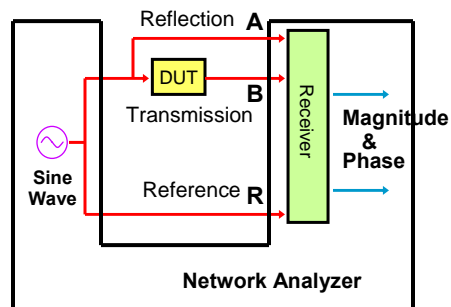
## Theory of Operation – TDR/VNA

### Impedance



Time Domain Reflectometer  
(TDR)

### S-parameters



Vector Network Analyzer  
(VNA)

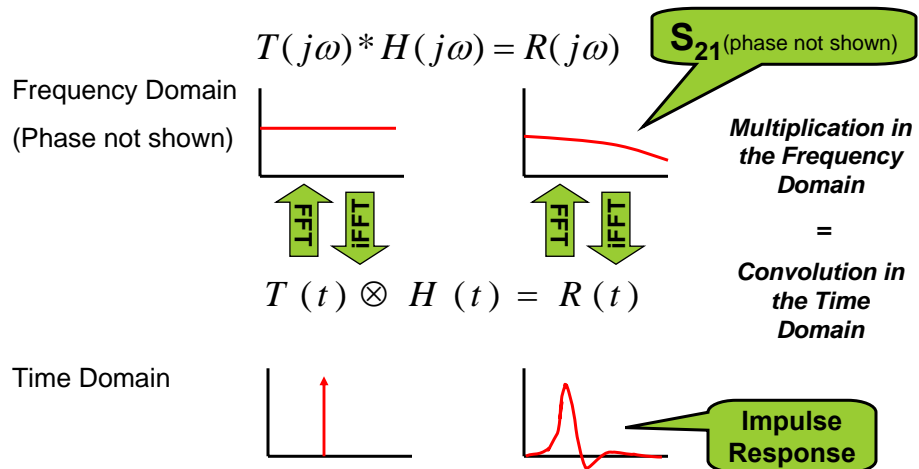
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## Scattering Parameters & Impulse Response



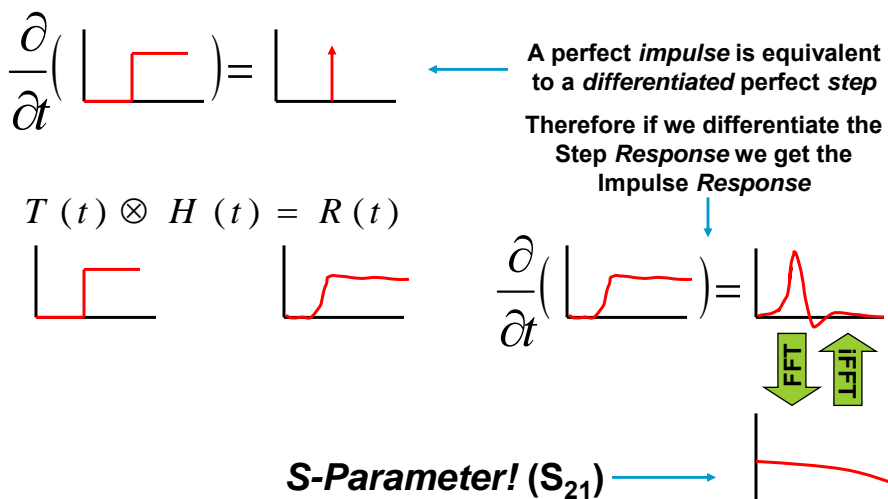
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## Step Response (TDR/TDT) vs Impulse Response



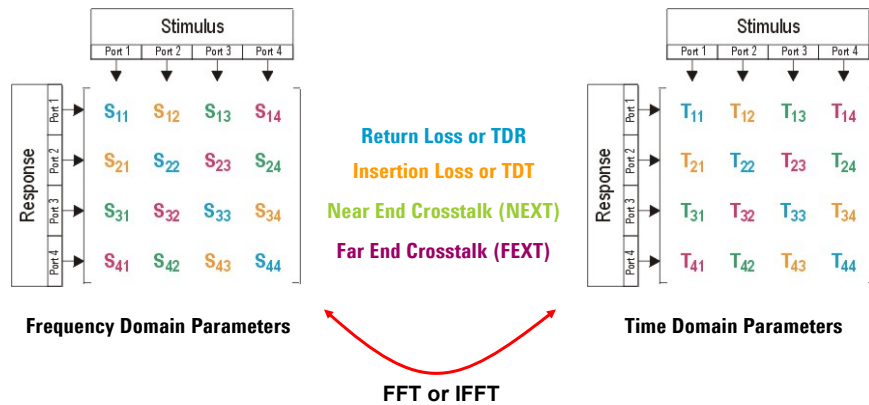
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## Single-ended S-Parameters and TDR/TDT



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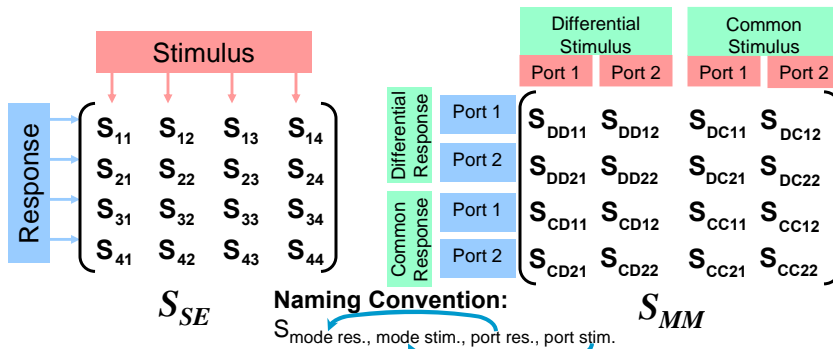
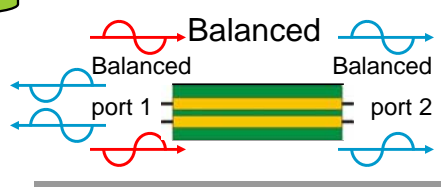
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## Single-ended to Differential S-Parameters

Network Analyzers typically use this method



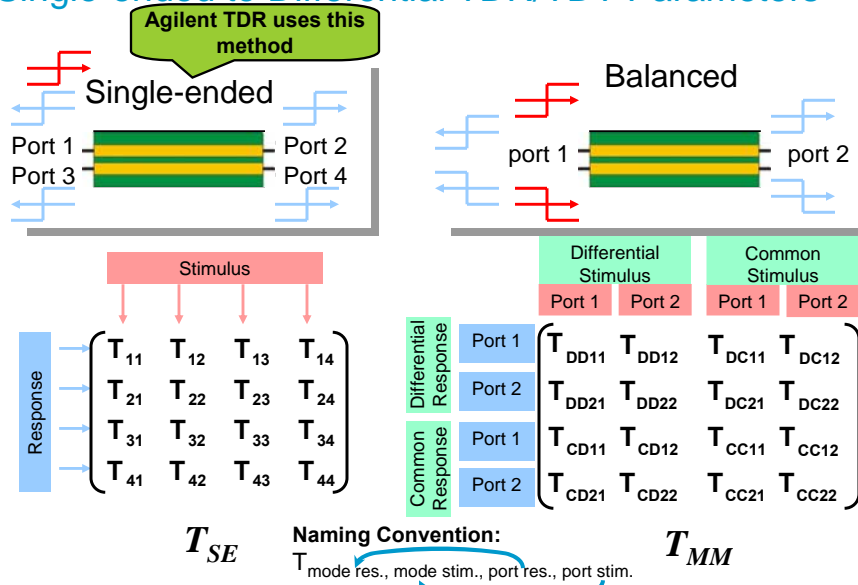
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## Single-ended to Differential TDR/TDT Parameters



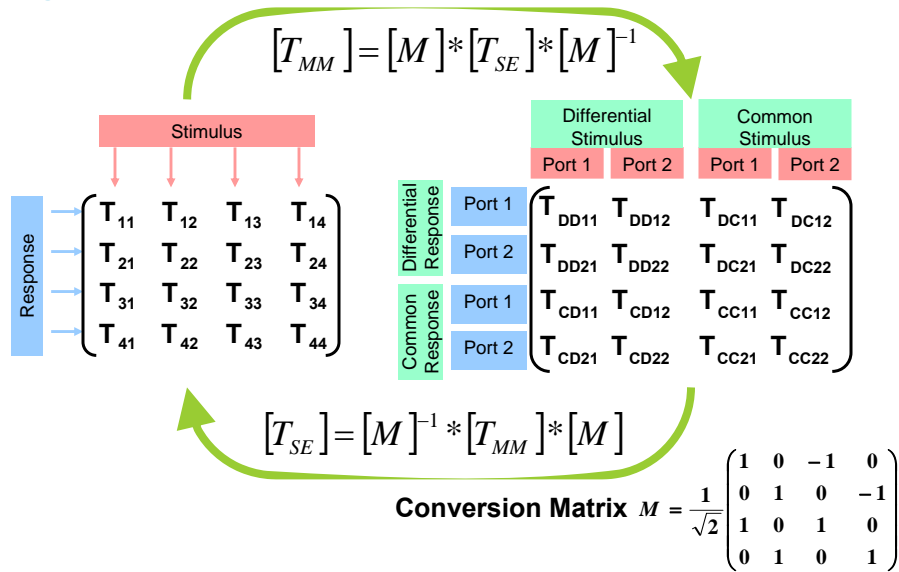
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## Single-ended to Differential TDR/TDT Parameters



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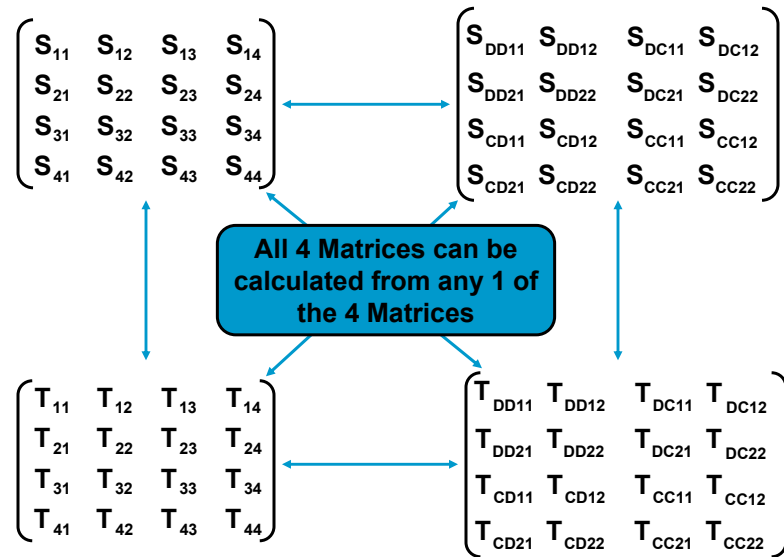
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## The 4 Matrices of a 4-Port Device



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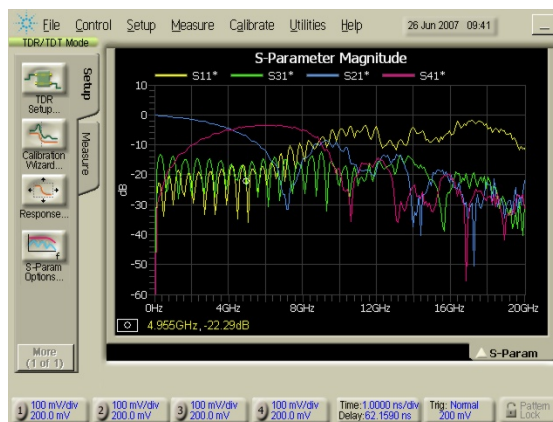
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## DCAj – S-Parameters

### Calibrated S-Parameters

- Real-time Update
- Built-in to the GUI



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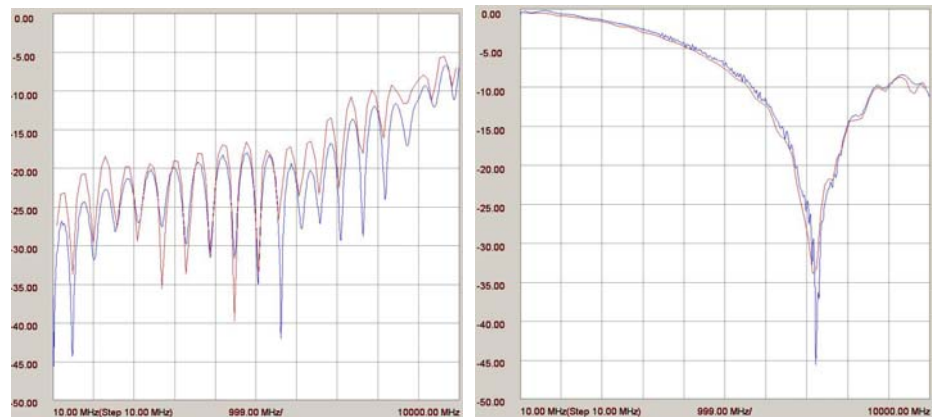
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## Correlation with Network Analyzer



**S11**

**S21**



• **Blue = 20GHz PNA**, **Red = DCAj**, Data compared with **PLTS**

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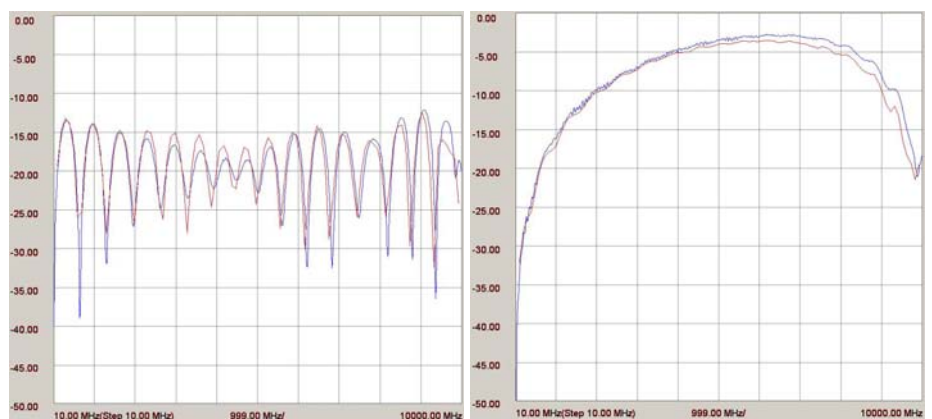
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## Correlation with Network Analyzer



**S31**

**S41**



• **Blue = 20GHz PNA**, **Red = DCAj**, Data compared with **PLTS**

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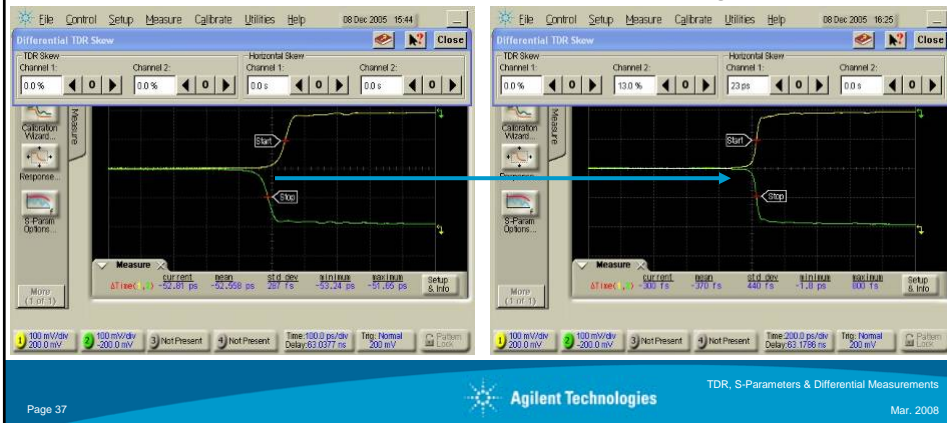
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## Differential Circuit Testing – What's Important?

- Differential Steps must be well matched
- Differential Channels must be de-skewed
  - use the TDR De-Skew procedure prior to making measurements



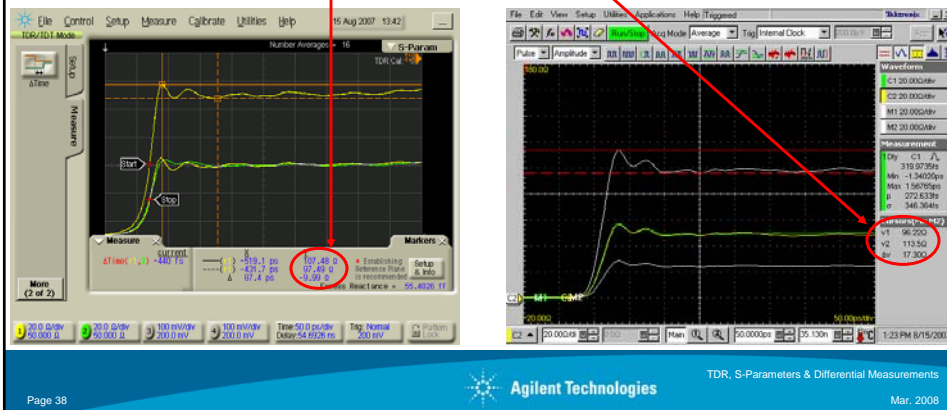
## Matching the Steps

When the TDR outputs are terminated with 50  $\Omega$  standards, there is no coupling so the Differential Impedance should be  $2 \times 50 \Omega = 100 \Omega$

Mismatch or overshoot will affect the resolution of the Differential Impedance measurement

DCAJ has ~10  $\Omega$   
(10%) variation

Tek CSA has ~17  $\Omega$   
(17%) variation



## Agilent Calibration

Agilent's built-in Calibration removes the effects of imperfect steps AND fixturing to give the **Truest Differential Impedance**.

DCAj has <1  $\Omega$   
(<1%) variation



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## More Information

**DCAj** - [www.agilent.com/find/dcaj](http://www.agilent.com/find/dcaj)

**High Precision Time Domain Reflectometry (AN 1304-7)**

**Measuring Differential Impedance with TDR to Improve High-Speed Bus Designs, (AN 1382-5)**

**Improving TDR/TDT Measurements Using Normalization (AN 1304-5)**

**PLTS** - [www.agilent.com/find/plts](http://www.agilent.com/find/plts)

### Signal Integrity Analysis Series

- Part 1: Single-Port TDR, TDR/TDT and 2-Port TDR - 5989-5763EN
- Part 2: 4-Port TDR/VNA/PLTS - 5989-5764EN
- Part 3: The ABCs of De-Embedding – 5989-5765EN



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